Conclusion: the direction with largest vill data variance is determined by an eigenvector associated to the largest eigenvalue of  $C = \frac{1}{2} \times XX^T$  or equivalently of  $XX^T$ .

To find the direction with the second longest data variance, we require this direction to be exthogonal to  $V^{(1)}$ 

Recall: projected data variance along  $v \in S^{H}$   $= v^{T}C v = \frac{1}{n} v^{T}(XX^{T})v$ Thus  $v^{(z)} = oney max v^{T}Cv$   $= v^{T}U || = ||v|| = ||v|$ 

From the previous proposition, V(2) is an

eigenventer associated to the second largest eigenvalue of C, or equivalently of XXT.

Continue as above, the direction that has the third largest data variance and is orthogonal to VII v(2) is determined by an eigenvector associated to the third largest eigenvalue of CorXXT

Thm: The d-dimensional subspace with the largest projected data variance is spanned by the deigenvectors associated to the delongest eigenvalues of CorXXT.

Remarks: (1) If  $X = U \Sigma V^T$  is the SVD, then

$$XX^T = U \Sigma \underline{V}^T V \Sigma^T U^T = U \Sigma \underline{\Sigma}^T U^T$$

Chicyoned.

is the eigenvalue decomposition of  $XX^T$ , so the eigenvectors associated to the d longest eigenvalues of  $XX^T$  are the first of columns of V = (4v - 4v)

(2) Criven a sample point X, the defined as

Proj  $X = (x^T u^{(j)}) u + \cdots + (x^T u^{(d)}) u^{(d)}$ spending  $u^{(j)}$ Scalar projection of x on  $u^{(j)}$ 

3.2 PCA: Geometric Bewpoint.

Q: Civen centered sample prints x! x x of R find a d-dimensional subspace S C R that best fit the sample points, 51 in the sense that the RT distances from the sample prints to S are minimized.

To compute the distances, let  $\{u', u'\}$  be an orthonormal basis of S, and  $\{u', u'\}$  of  $S^{\perp}$  be an orthonormal basis of  $S^{\perp}$ .

Then  $\{u', u'\}$  is an orthonormal basis of  $\mathbb{R}^{1}$ .

To a sample point  $x^{(i)}$ , we have

